Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/550,563	JENSEN ET AL.	
Examiner	Art Unit	
Jacob Cheu	1641	

SEARCHED				
Class	Subclass	Date	Examiner	
435	7.1	8/10/2007	JC	
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	7.92			
436	516			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East Stic Palm (inventor search)	8/10/2007	JC	
Cyphated Feah	114.8	X	
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